

**Search Notes**

Application/Control No.

10/749,816

Examiner

Shih-wen Hsieh

Applicant(s)/Patent under  
Reexamination

BIBL ET AL.

Art Unit

2861

**SEARCHED**

Class	Subclass	Date	Examiner
347	updated	4/29/2006	SWH
216	updated	4/29/2006	SWH
29	updated	4/29/2006	SWH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR